



LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO.

9772-279-999

APPLICATION NO.

10/005,923

APPLICANT

Flanagan & Leino

FILING DATE

December 4, 2001

GROUP

2122

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SSR	AA	5,987,252	11/16/99	Leino et al.	392	704	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

SSR	AB	Detlefs, David, "An overview of the extended static checking system," <i>Proceedings of The First Workshop on Formal Methods in Software Practice</i> , pp. 1-9 (Jan. 1996)					
SSR	AC	Flanagan et al., "Annotation Inference for Modular Checkers," <i>Information Processing Letters</i> , 77: 97-108 (Feb. 2001)					
SSR	AD	Flanagan, Cormac and Leino, K. R. M., "Houdini, an Annotation Assistant for ESC/Java," <i>SRC Technical Note 2000-003</i> (Dec. 31, 2000).					
SSR	AE	Intrinsa Corp., "A Technical Introduction to PREFIX/Enterprise" (1998).					
SSR	AF	Leino et al., "Checking Java Programs via Guarded Commands," <i>SRC Technical Note 1999-002</i> , Compaq Computer Corporation (May 21, 1999)					
	AG	Leino et al., "ESC/Java User's Manual," <i>Technical Note 2000-002</i> , Compaq Systems Research Center (Oct. 2000).					
	AH	Levine et al., "lex & yacc" (2nd ed.) (O'Reilly Publ. 1992).					
	AI	Leino, K. R. M. and Nelson, G., "An extended static checker for Modula-3," <i>In Compiler Construction: 7th International Conference, CC'98</i> (Kai Koskimies, ed.), volume 1383 of Lecture Notes in Computer Science, pp. 302-305 (April 1998) (Springer-Verlag 1998).					
	AJ	Millstein, "Toward More Informative ESC/Java Warning Messages," at http://gatekeeper.research.compaq.com/pub/DEC/SRC/technical-notes/SRC-1999-003-html/millstein.html . (1999) (last accessed Nov. 21, 2001).					
	AK	Savage et al., "Eraser: A Dynamic Data Race Detector for Multi-Threaded Programs," <i>ACM Transactions on Computer Systems</i> , vol. 15, no. 4, pp. 391-411 (Nov. 1997)					

EXAMINER

DATE CONSIDERED

1/25/2005

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.